

FORM PTO 1449 (modified)

ATTY DOCKET NO.
684.2925APPLICATION NO.
09/428,490U.S. DEPARTMENT OF COMMERCE
PATENT AND TRADEMARK OFFICELIST OF REFERENCES CITED BY APPLICANT(S)
(Use several sheets if necessary)

Submitted to the PTO: August 16, 2000

APPLICANT
HIDEKI INA, ET AL.FILING DATE
October 28, 1999GROUP
2873

U.S. PATENT DOCUMENTS

*EXAMINER	DOCUMENT						FILING DATE

FOREIGN PATENT DOCUMENTS

	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES/NO/ OR ABSTRACT

OTHER DOCUMENT(S) (Including Author, Title, Date, Pertinent Pages, Etc.)

<i>for</i>	Hiroshi Kubota, "Wave Optics", Iwanami Shoten Co., pp. 414-415.
<i>✓</i>	"Needs and Seeds of Optical Measurement", edited by Shadan-Hojin Keiryo Kanri Kyokai and Hikari Oyou Keisoku Gijutsu Chosa Kenkyu linkai, Corona Co., pp. 228-229.
<i>✓</i>	"New Optical Microscopes", Vol. 1, "Theory and Practice of Laser Microscopes", supervised by Tetsuya Fujita, edited by Minoru Kawada, Gakusai-Kikaku Co., pp. 82-83.

EXAMINER

PMW

DATE CONSIDERED

7/10/2

*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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Sheet 1 of 1

FORM PTO 1449 (modified) U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE LIST OF REFERENCES CITED BY APPLICANT(S) (Use several sheets if necessary) April 10, 2002				ATTY DOCKET NO. 00684.002925.	APPLICATION NO. 09/428,490		
				APPLICANT Hideki INA et al.			
				FILING DATE October 28, 1999		GROUP 2873	
U.S. PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
<i>J. Car</i>		4,869,593	09/26/1989	Biegen	356	351	
		5,783,342	07/21/1998	Yamashita et al.	430	30	
		5,438,413	08/01/1995	Mazor et al.	356	363	
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		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES/NO/ OR ABSTRACT
<i>J. Car</i>		WO 97/40422	10/30/1997	PCT			
OTHER DOCUMENT(S) (Including Author, Title, Date, Pertinent Pages, Etc.)							
EXAMINER 				DATE CONSIDERED <i>7/10/2</i>			

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